

TSD2922

RF & MICROWAVE TRANSISTORS HF/VHF/UHF N-CHANNEL MOSFETS

PRODUCT DEVELOPMENT DATA SHEET

This data sheet contains the design criteria and target specifications for a product which is currently under development by SGS-THOMSON. The design criteria and specifications of this item could change prior to introduction and SGS-THOMSON assumes no liability for use of information contained herein.

- GOLD METALLIZATION
- NO THERMAL RUNAWAY
- COMMON SOURCE CONFIGURATION
- POUT = 300W MIN. WITH 12 dB GAIN



DESCRIPTION

The TSD2922 is a gold metallized N-Channel MOS field-effect RF power transistor. The TSD2922 is intended for use in 50 V dc large signal applications up to 200 MHz.



ABSOLUTE MAXIMUM RATINGS $(T_{case} = 25^{\circ}C)$

| Symbol | Parameter | Value | Unit | |
|----------------------|----------------------|--------------|------|--|
| V _{(BR)DSS} | Drain-Source Voltage | 125 | V | |
| V _{DGR} | Drain-Gate Voltage | 125 | V | |
| V _{GS} | Gate-Source Voltage | ± 30 | V | |
| ١D | Drain Current | TBD | А | |
| PDISS | Power Dissipation | 500 | W | |
| TJ | Junction Temperature | +200 | °C | |
| T _{STG} | Storage Temperature | - 65 to +150 | °C | |

THERMAL DATA

| R _{TH(j-c)} Junction-Case Thermal Resistance | .35 | °C/W |
|---|-----|------|
|---|-----|------|

ELECTRICAL SPECIFICATIONS ($T_{case} = 25^{\circ}C$)

STATIC

| Symbol | Toot Conditions | | | Value | | | Linit | |
|----------------------|-------------------|-----|--------------------------|----------|------|------|-------|------|
| Symbol | Test Conditions | | | | Min. | Тур. | Max. | Unit |
| V _{(BR)DSS} | V _{GS} = | 0V | I _{DS} = 100 mA | | 125 | | | V |
| I _{DSS} | $V_{GS} =$ | 0V | $V_{DS} = 50V$ | | — | | 5.0 | mA |
| G _{FS} | $V_{DS} =$ | 10V | I _D = 5A | | 4 | | _ | mhos |
| Ciss | $V_{GS} =$ | 0V | $V_{DS} = 50V$ | F = 1MHz | — | | | V |
| Coss | V _{GS} = | 0V | $V_{DS} = 50V$ | F = 1MHz | — | | | mA |
| Crss | $V_{GS} =$ | 0V | $V_{DS} = 50V$ | F = 1MHz | | | | _ |
| V _{GS(TH)} | V _{DS} = | 10V | I _D = 250 mA | | 1 | | 5 | _ |

DYNAMIC

| Symbol | Test Conditions | | | | Value | | | Unit | |
|-----------------|-----------------|---------|-----------------|-------------------|--------|------|----|------|----|
| | | | Min. | Тур. | Max. | Onit | | | |
| PL | f = | 175 MHz | $V_{DS} = 50 V$ | I _{DQ} = | 500 mA | 300 | | — | W |
| G _{PS} | f = | 175 MHz | $V_{DS} = 50 V$ | $I_{DQ} =$ | 500 mA | 12 | 13 | — | dB |
| η_D | f = | 175 MHz | $V_{DS} = 50 V$ | $I_{DQ} =$ | 500 mA | 50 | 60 | — | % |



PACKAGE MECHANICAL DATA



Information furnished is believed to be accurate and reliable. However, SGS-THOMSON Microelectronics assumes no responsibility for the consequences of use of such information nor for any infringement of patents or other rights of third parties which may result from its use. No license is granted by implication or otherwise under any patent or patent rights of SGS-THOMSON Microelectronics. Specifications mentioned in this publication are subject to change without notice. This publication supersedes and replaces all information previously supplied. SGS-THOMSON Microelectronics products are not authorized for use as critical components in life support devices or systems without express written approval of SGS-THOMSON Microelectronics.

©1996 SGS-THOMSON Microelectronics - All Rights Reserved

SGS-THOMSON Microelectronics GROUP OF COMPANIES Australia - Brazil - Canada - China - France - Germany - Hong Kong - Italy - Japan - Korea Malaysia - Malta - Morocco - The Netherlands - Singapore - Spain - Sweden - Switzerland Taiwan - Thailand - United Kingdom - U.S.A.

